

<b>Notice of References Cited</b>	Application/Control No. 09/725,393		Applicant(s)/Patent Under Reexamination DAS ET AL.	
	Examiner Paul R. Myers		Art Unit 2111	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,111,912	08-2000	Cohen et al.	375/225
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Punctured Convolutional Codes of Rate (n-1)/n and Simplified Maximum Likelihood Decoding by Cain et al pages 97-100, IEEE Transactions on Information Technology, Vol it-25, No 1 January 1979.
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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